

Silicon Carbide (SiC) MOSFET - EliteSiC, 40 mohm, 1200 V, M1, Die NTC040N120SC1

Description

Silicon Carbide (SiC) MOSFET uses a completely new technology that provide superior switching performance and higher reliability compared to Silicon. In addition, the low ON resistance and compact chip size ensure low capacitance and gate charge. Consequently, system benefits include highest efficiency, faster operation frequency, increased power density, reduced EMI, and reduced system size.

Features

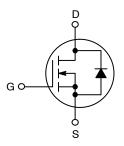
- 1200 V @ $T_J = 175$ °C
- Typ $R_{DS(on)} = 40 \text{ m}\Omega$ at $V_{GS} = 20 \text{ V}$, $I_D = 40 \text{ A}$
- High Speed Switching with Low Capacitance
- 100% UIL Tested
- This Device is Halide Free and RoHS Compliant with exemption 7a, Pb–Free 2LI (on second level interconnection)

Applications

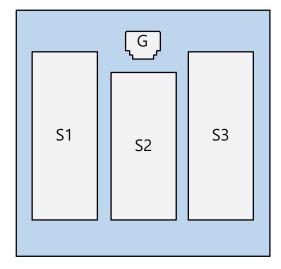
- Industrial Motor Drive
- UPS
- Boost Inverter
- PV Charger

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
1200 V	56 mΩ @ 20 V	60 A

N-CHANNEL MOSFET



DIE DIAGRAM

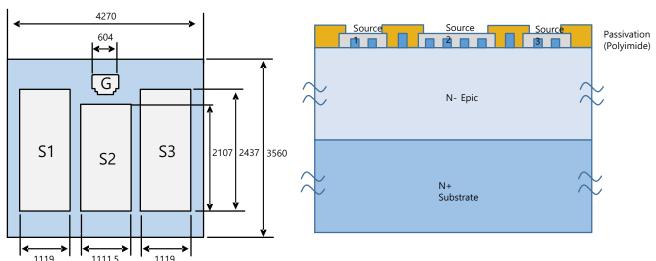


Die Information

 Wafer Diameter 	6 inch		
Die Size	4,270 x 3,560 μm		
 Metallization 			
. Тор	Ti/TiN/Al	5 μm	
· Back	Ti/NiV/Ag		
 Die Thickness 	Typ. 200 μm		
 Gate Pad Size 	604 x 415 μm		

Die Layout

Die Cross Section



Passivation Information

- Passivation Material: Polymide (PSPI)
- Passivation Type: Local Passivation
- Passivation Thickness 10 μm
 - : Passivation Area

Die Layout

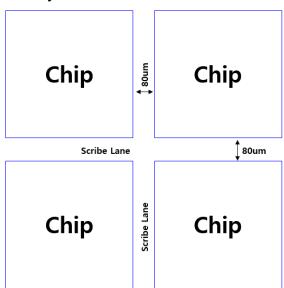


Figure 1. Bare Die Dimensions

MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)

Parame	Symbol	Value	Unit		
Drain-to-Source Voltage			V _{DSS}	1200	V
Gate-to-Source Voltage			V_{GS}	-15/+25	V
Recommended Operation Values of Gate-to-Source Voltage	T _C < 175°C		V_{GSop}	-5/+20	V
Continuous Drain Current $R_{\theta JC}$	Steady State	T _C = 25°C	I _D	60	Α
Power Dissipation $R_{\theta JC}$			P _D	348	W
Continuous Drain Current $R_{\theta JC}$	Steady State	T _C = 100°C	I _D	42	Α
Power Dissipation $R_{\theta JC}$			P _D	174	W
Pulsed Drain Current (Note 2)	7	_C = 25°C	I _{DM}	240	Α
Single Pulse Surge Drain Current Capability	T _C = 25°C, t	$_{0}$ = 10 μs, R_{G} = 4.7 Ω	I _{DSC}	416	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			Is	34	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 35 A, L = 1 mH) (Note 3)			E _{AS}	613	mJ

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Note 1)	$R_{ hetaJC}$	0.43	°C/W

^{1.} The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

^{2.} Repetitive rating, limited by max junction temperature. 3. E_{AS} of 613 mJ is based on starting $T_J = 25^{\circ}C$; L = 1 mH, $I_{AS} = 35$ A, $V_{DD} = 120$ V, $V_{GS} = 20$ V.

ELECTRICAL CHARACTERISTICS (T_{.I} = 25°C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
OFF CHARACTERISTICS	1					
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 1 mA	1200	_	-	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	I _D = 1 mA, referenced to 25°C	-	450	-	mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 1200 V, T _J = 25°C	-	-	100	μΑ
		V _{GS} = 0 V, V _{DS} = 1200 V, T _J = 175°C	-	_	250	
Gate-to-Source Leakage Current	I _{GSS}	V _{GS} = +25/-15 V, V _{DS} = 0 V	-	_	±1	μΑ
ON CHARACTERISTICS						
Gate Threshold Voltage	V _{GS(th)}	$V_{GS} = V_{DS}$, $I_D = 10 \text{ mA}$	1.8	2.97	4.3	V
Recommended Gate Voltage	V_{GOP}		-5	-	+20	V
Drain-to-Source On Resistance	R _{DS(on)}	$V_{GS} = 20 \text{ V}, I_D = 35 \text{ A}, T_J = 25^{\circ}\text{C}$	-	39	56	mΩ
		V _{GS} = 20 V, I _D = 35 A, T _J = 150°C	-	60	-	
Forward Transconductance	9FS	V _{DS} = 20 V, I _D = 35 A	-	20	_	S
CHARGES, CAPACITANCES & GATE	RESISTANCE					
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 800 V	-	1781	_	pF
Output Capacitance	Coss]	-	140	-	
Reverse Transfer Capacitance	C _{RSS}]	_	12	-	
Total Gate Charge	Q _{G(tot)}	$V_{GS} = -5/20 \text{ V}, V_{DS} = 600 \text{ V}, I_D = 47 \text{ A}$	_	106	-	nC
Threshold Gate Charge	Q _{G(th)}]	_	16	-	
Gate-to-Source Charge	Q _{GS}	1	_	34	-	
Gate-to-Drain Charge	Q _{GD}	1	_	26	-	
Gate Resistance	R _G	f = 1 MHz	_	2.2	-	Ω
SWITCHING CHARACTERISTICS	•			•		
Turn-On Delay Time	t _{d(on)}	$V_{GS} = -5/20 \text{ V}, V_{DS} = 800 \text{ V},$	-	18	-	ns
Rise Time	t _r	I_D = 47 A, R_G = 4.7 Ω , Inductive Load	_	41	-	
Turn-Off Delay Time	t _{d(off)}]	_	33	-	
Fall Time	t _f]	_	10.4	-	
Turn-On Switching Loss	E _{ON}]	_	1003	-	μJ
Turn-Off Switching Loss	E _{OFF}]	_	247	-	
Total Switching Loss	E _{TOT}]	-	1248	-	
DRAIN-SOURCE DIODE CHARACTE	RISTICS					
Continuous Drain-to-Source Diode Forward Current	I _{SD}	V _{GS} = -5 V	-	_	34	Α
Pulsed Drain-to-Source Diode Forward Current (Note 2)	I _{SDM}	V _{GS} = -5 V	-	-	240	Α
Forward Diode Voltage	V_{SD}	V _{GS} = -5 V, I _{SD} = 17.5 A	-	3.8	_	V
Reverse Recovery Time	t _{RR}	V _{GS} = -5/20 V, I _{SD} = 47 A,	_	24	-	ns
Reverse Recovery Charge	Q _{RR}	dl _S /dt = 1000 A/μs	_	125	-	nC
Reverse Recovery Energy	E _{REC}]	_	8.5	-	μJ
Peak Reverse Recovery Current	I _{RRM}]	_	10.4	-	Α
Charge Time	ta	1	_	12.4	-	ns
Discharge Time	t _b]	_	11.6	-	ns
	•					

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

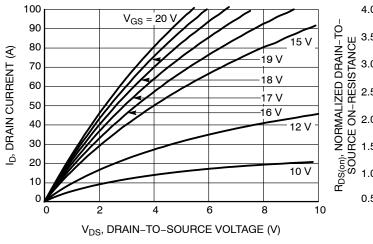


Figure 2. On-Region Characteristics

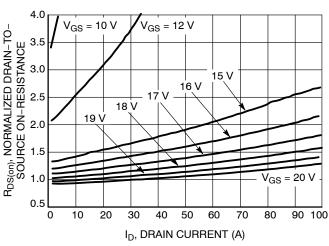


Figure 3. Normalized On-Resistance vs. Drain Current and Gate Voltage

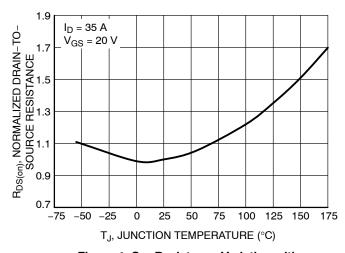


Figure 4. On–Resistance Variation with Temperature

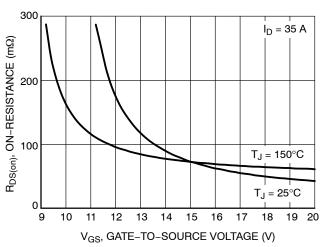


Figure 5. On-Resistance vs. Gate-to-Source Voltage

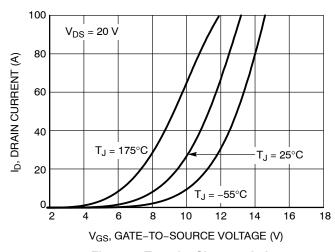


Figure 6. Transfer Characteristics

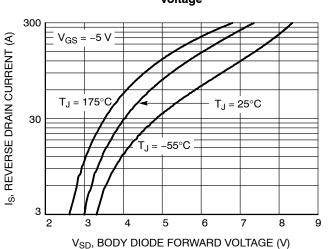


Figure 7. Diode Forward Voltage vs. Current

TYPICAL CHARACTERISTICS ($T_J = 25$ °C unless otherwise noted) (continued)

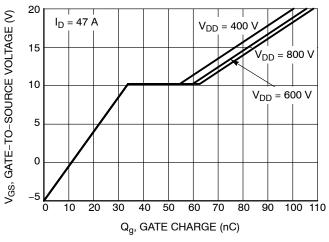


Figure 8. Gate-to-Source Voltage vs. Total Charge

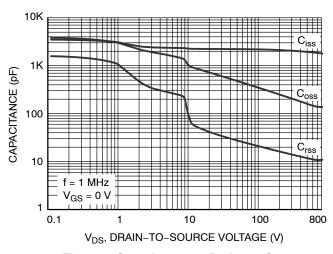


Figure 9. Capacitance vs. Drain-to-Source Voltage

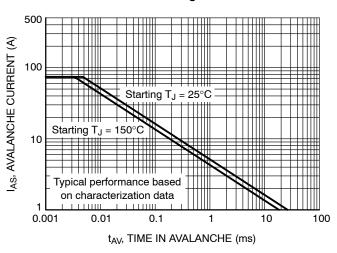


Figure 10. Unclamped Inductive Switching Capability

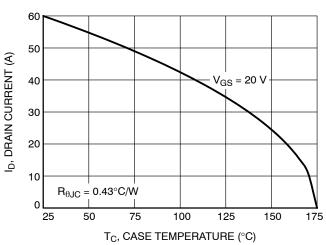


Figure 11. Maximum Continuous Drain Current vs. Case Temperature

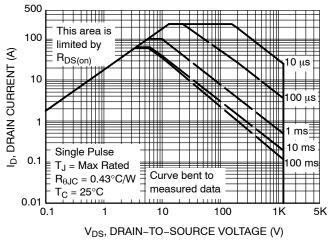


Figure 12. Safe Operating Area

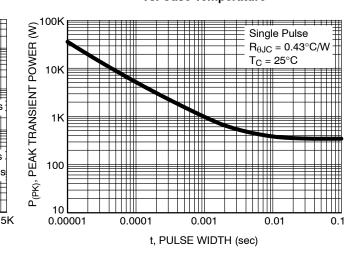


Figure 13. Single Pulse Maximum Power Dissipation

$\textbf{TYPICAL CHARACTERISTICS} \ (T_J = 25^{\circ}C \ unless \ otherwise \ noted) \ (continued)$

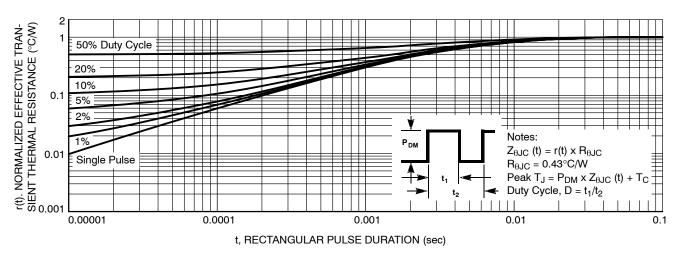


Figure 14. Junction-to-Ambient Thermal Response

ORDERING INFORMATION AND PACKAGE MARKING

Orderable Part Number	Top Marking	Package	Packing Method	Reel Size	Tape Width	Quantity
NTC040N120SC1	No Marking	Die	Wafer	N/A	N/A	N/A

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using **onsemi** products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by **onsemi**. "Typical" parameters which may be provided in **onsemi** data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. **onsemi** does not convey any license under any of its intellectual property rights nor the rights of others. **onsemi** products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use **onsemi** products for any such unintended or unauthorized application, Buyer shall indemnify and hold **onsemi** and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that **onsemi** was negligent regarding the design or manufacture of the part. **onsemi** is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

ADDITIONAL INFORMATION

TECHNICAL PUBLICATIONS:

 $\textbf{Technical Library:} \ \underline{www.onsemi.com/design/resources/technical-documentation}$

onsemi Website: www.onsemi.com

ONLINE SUPPORT: www.onsemi.com/support

For additional information, please contact your local Sales Representative at

www.onsemi.com/support/sales